## Search Notes



Application/Control No.
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10602355

Applicant(s)/Patent Under Reexamination SCHIFF, LEONARD N.

Examiner

RICHARD CHAN

Art Unit 2618

SEARCHED							
Class	Subclass	Date	Examiner				
455	12.1, 427, 428, 11.1, 13.1, 13.2,	5/17/11	RC				

SEARCH NOTES				
Search Notes	Date	Examiner		
Consulted Raymond Dean (Primary) regarding prior art search	1/16/12	RC		
Consulted Yuwen Pan for prior art and 112 1st paragraph rejection for claim 28	1/29/12	RC		

INTERFERENCE SEARCH				
Class	Subclass	Date	Examiner	

/RICHARD CHAN/ Examiner.Art Unit 2618	

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